

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In te the Application of

Makoto KOBAYASHI et al.

Group Art Unit: 3723

411 | RCE M. Wats 11/24/02

Application No.: 09/830,434

Examiner:

H. Shakeri

Filed: April 26, 2001

Docket No.: 109352

For: POLISHING PAD AND POLISHING METHOD FOR SEMICONDUCTOR WAFER

LARGE ENTITY REQUEST FOR CONTINUED EXAMINATION UNDER 37 C.F.R. §1.114

Director of the U.S. Patent and Trademark Office Washington, D.C. 20231

Sir:

In accordance with the provisions of 37 C.F.R. §1.114, Applicants hereby request continued examination and entry and consideration of the October 28, 2002 submission. The above-identified application was filed on or after June 8, 1995. Thus, entry is proper under 37 C.F.R. §1.114(d).

Attached hereto is our check no. 136399 in the amount of \(\subseteq \) \$740.00 as payment of the fees set forth in 37 C.F.R. \(\) \(1.17(e) \). The Director is hereby authorized to charge any additional fees or credit any overpayment associated with this communication to Deposit Account No.

15-0461. Two duplicate copies of this page are enclosed.

Respectfully submitted,

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WPB:CWB/rxg

Date: November 20, 2002

OLIFF & BERRIDGE, PLC P.O. Box 19928 Alexandria, Virginia 22320 Telephone: (703) 836-6400 DEPOSIT ACCOUNT USE AUTHORIZATION Please grant any extension necessary for entry; Charge any fee due to our Deposit Account No. 15-0461

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